

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/656,886	LAAKKONEN, KIMMO	
Examiner Brian P. Whipple		Art Unit 2152	Page 1 of 1	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,493,692 A	02-1996	Theimer et al.	455/26.1
*	B	US-6,920,483 B1	07-2005	Cordray et al.	709/206
*	C	US-6,748,450 B1	06-2004	Dutta, Rabindranath	709/246
*	D	US-6,396,513 B1	05-2002	Helfman et al.	715/752
*	E	US-7,082,439 B1	07-2006	Hickman et al.	707/104.1
*	F	US-2002/0026513 A1	02-2002	Hoglund et al.	709/227
*	G	US-7,076,529 B2	07-2006	Koch et al.	709/206
*	H	US-6,237,027 B1	05-2001	Namekawa, Nobuo	709/206
*	I	US-7,181,495 B2	02-2007	Skladman et al.	709/206
*	J	US-6,400,810 B1	06-2002	Skladman et al.	379/93.24
*	K	US-2004/0122905 A1	06-2004	Smith et al.	709/206
*	L	US-6,320,941 B1	11-2001	Tyroler, Dan	709/206
*	M	US-2003/0120775 A1	06-2003	York, Justin E.	709/224

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.